Ignition IGBT 18 Amps, 400 Volts

N-Channel D²PAK

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Overvoltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

Features

- Ideal for Coil-on-Plug Applications
- Gate-Emitter ESD Protection
- Temperature Compensated Gate–Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- New Design Increases Unclamped Inductive Switching (UIS) Energy Per Area
- Low Threshold Voltage to Interface Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Integrated Gate-Emitter Resistor (R_{GE})
- Emitter Ballasting for Short-Circuit Capability
- These are Pb-Free Devices

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

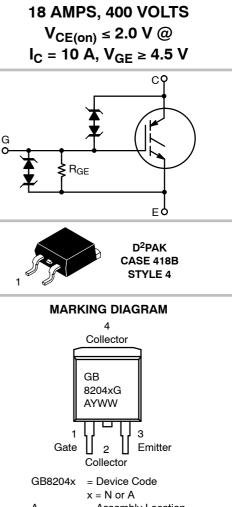
| Rating | Symbol | Value | Unit |
|--|-----------------------------------|----------------|------------------------------------|
| Collector-Emitter Voltage | V _{CES} | 430 | V _{DC} |
| Collector-Gate Voltage | V _{CER} | 430 | V _{DC} |
| Gate-Emitter Voltage | V_{GE} | 18 | V _{DC} |
| Collector Current–Continuous @ T _C = 25°C – Pulsed | Ι _C | 18 50 | A _{DC} A _{AC} |
| ESD (Human Body Model) R = 1500 Ω , C = 100 pF | ESD | 8.0 | kV |
| ESD (Machine Model) R = 0 Ω , C = 200 pF | ESD | 800 | V |
| Total Power Dissipation @ T _C = 25°C Derate above 25°C | P _D | 115 0.77 | W W/°C |
| Operating and Storage Temperature Range | T _J , T _{stg} | –55 to +175 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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| A | = Assembly Location |
|----|---------------------|
| Υ | = Year |
| WW | = Work Week |
| G | = Pb-Free Package |

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|---------------------------------|-----------------------|
| NGB8204NT4G | D ² PAK (Pb-Free) | 800 / Tape & Reel |
| NGB8204ANT4G | D ² PAK (Pb-Free) | 800 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

UNCLAMPED COLLECTOR-TO-EMITTER AVALANCHE CHARACTERISTICS (-55° \leq T_J \leq 175°C)

| Characteristic | Symbol | Value | Unit |
|---|--------------------|------------|------|
| Single Pulse Collector-to-Emitter Avalanche Energy $V_{CC} = 50 \text{ V}, \text{ V}_{GE} = 5.0 \text{ V}, \text{ Pk I}_{L} = 21.1 \text{ A}, \text{ L} = 1.8 \text{ mH}, \text{ Starting T}_{J} = 25^{\circ}\text{C}$ $V_{CC} = 50 \text{ V}, \text{ V}_{GE} = 5.0 \text{ V}, \text{ Pk I}_{L} = 18.3 \text{ A}, \text{ L} = 1.8 \text{ mH}, \text{ Starting T}_{J} = 125^{\circ}\text{C}$ | E _{AS} | 400 300 | mJ |
| Reverse Avalanche Energy V _{CC} = 100 V, V _{GE} = 20 V, Pk I _L = 25.8 A, L = 6.0 mH, Starting T _J = 25°C | E _{AS(R)} | 2000 | mJ |
| MAXIMUM SHORT-CIRCUIT TIMES ($-55^{\circ}C \le T_{J} \le 150^{\circ}C$) | | | |
| Short Circuit Withstand Time 1 (See Figure 17, 3 Pulses with 10 ms Period) | t _{sc1} | 750 | μs |
| Short Circuit Withstand Time 2 (See Figure 18, 3 Pulses with 10 ms Period) | t _{sc2} | 5.0 | ms |

THERMAL CHARACTERISTICS

| Characteristic | | Symbol | Value | Unit |
|--|--|------------------|-------|------|
| Thermal Resistance, Junction-to-Case | | $R_{\theta JC}$ | 1.3 | °C/W |
| Thermal Resistance, Junction-to-Ambient | D ² PAK (Note 1) | R _{0JA} | 50 | °C/W |
| Maximum Lead Temperature for Soldering Purposes, | Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds (Note 2) | | 275 | °C |

1. When surface mounted to an FR4 board using the minimum recommended pad size.

2. For further details, see Soldering and Mounting Techniques Reference Manua, SOLDERRM/D.

ELECTRICAL CHARACTERISTICS

| Characteristic | Symbol | Test Conditions | Temperature | Min | Тур | Max | Unit |
|--|----------------------|---|--|-----|-----|-----|------------------|
| OFF CHARACTERISTICS | <u> </u> | | | | • | • | • |
| Collector-Emitter Clamp Voltage | BV _{CES} | I _C = 2.0 mA | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 380 | 395 | 420 | V _{DC} |
| | | I _C = 10 mA | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 390 | 405 | 430 | |
| Zero Gate Voltage Collector Current | I _{CES} | | T _J = 25°C | - | 2.0 | 10 | μA _{DC} |
| | | V _{CE} = 350 V, V _{GE} = 0 V | T _J = 150°C | - | 10 | 40* | |
| | | -GE 01 | $T_J = -40^{\circ}C$ | - | 1.0 | 10 | |
| Reverse Collector-Emitter Leakage Current | I _{ECS} | | T _J = 25°C | - | 0.7 | 1.0 | mA |
| | | $V_{CE} = -24 V$ | T _J = 150°C | - | 12 | 25* | |
| | | | $T_J = -40^{\circ}C$ | - | 0.1 | 1.0 | |
| Reverse Collector-Emitter Clamp | B _{VCES(R)} | | T _J = 25°C | 27 | 33 | 37 | V _{DC} |
| Voltage | | I _C = -75 mA | T _J = 150°C | 30 | 36 | 40 | |
| | | | $T_J = -40^{\circ}C$ | 25 | 32 | 35 | |
| Gate-Emitter Clamp Voltage | BV _{GES} | I _G = 5.0 mA | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 11 | 13 | 15 | V _{DC} |
| Gate-Emitter Leakage Current | I _{GES} | V _{GE} = 10 V | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 384 | 640 | 700 | μA _{DC} |
| Gate Emitter Resistor | R _{GE} | - | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 10 | 16 | 26 | kΩ |

ON CHARACTERISTICS (Note 3)

| Gate Threshold Voltage | V _{GE(th)} | | $T_J = 25^{\circ}C$ | 1.1 | 1.4 | 1.9 | V _{DC} |
|--|---------------------|---|------------------------|------|-----|------|-----------------|
| | | I _C = 1.0 mA, V _{GE} = V _{CE} | T _J = 150°C | 0.75 | 1.0 | 1.4 | |
| | | | $T_J = -40^{\circ}C$ | 1.2 | 1.6 | 2.1* | |
| Threshold Temperature Coefficient (Negative) | - | - | - | I | 3.4 | - | mV/°C |

*Maximum Value of Characteristic across Temperature Range.

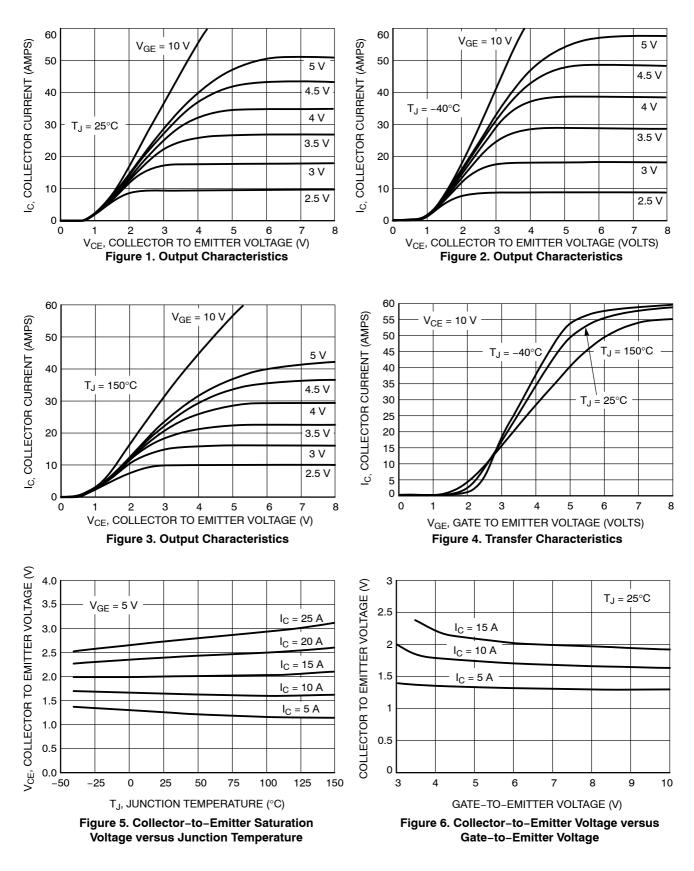
3. Pulse Test: Pulse Width \leq 300 μ S, Duty Cycle \leq 2%.

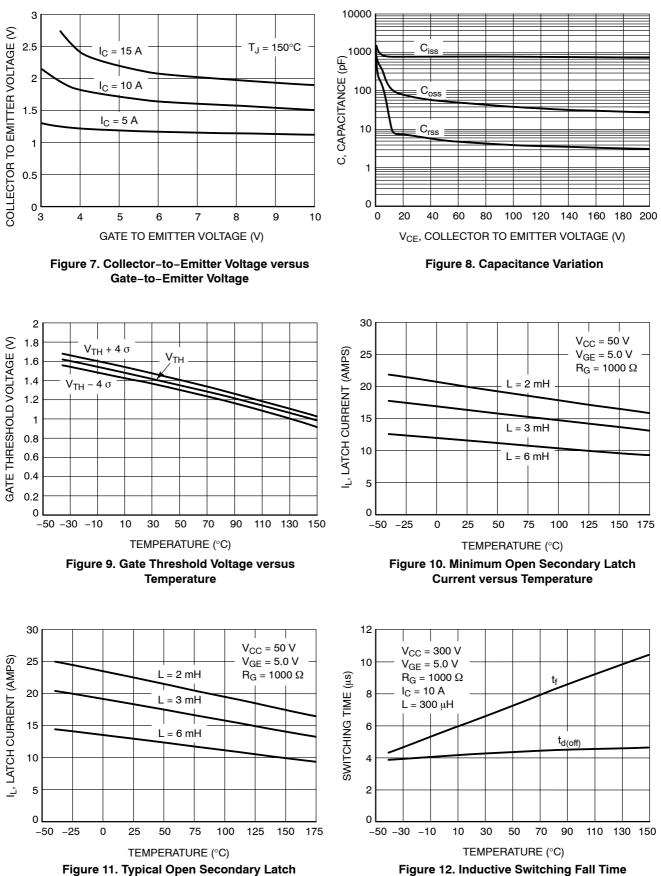
ELECTRICAL CHARACTERISTICS

| Characteristic | Symbol | Test Conditions | Temperature | Min | Тур | Max | Unit |
|---------------------------------|---------------------|--|--|-----|------|------|-----------------|
| ON CHARACTERISTICS (Note 3) | | | | | • | • | • |
| Collector-to-Emitter On-Voltage | V _{CE(on)} | V _{CE(on)} I _C = 6.0 A, V _{GE} = 4.0 V | $T_J = 25^{\circ}C$ | 1.0 | 1.4 | 1.6 | V _{DC} |
| | | | T _J = 150°C | 0.9 | 1.3 | 1.6 | |
| | | | $T_J = -40^{\circ}C$ | 1.1 | 1.45 | 1.7* | |
| | | | $T_J = 25^{\circ}C$ | 1.3 | 1.6 | 1.9* | |
| | | I _C = 8.0 A, V _{GE} = 4.0 V | T _J = 150°C | 1.2 | 1.55 | 1.8 | |
| | | VGE - 4.0 V | $T_J = -40^{\circ}C$ | 1.4 | 1.6 | 1.9* | |
| | | | $T_J = 25^{\circ}C$ | 1.4 | 1.8 | 2.0 | |
| | | I _C = 10 A, V _{GE} = 4.0 V | T _J = 150°C | 1.5 | 1.8 | 2.0 | |
| | | VGE - 4.0 V | $T_J = -40^{\circ}C$ | 1.4 | 1.8 | 2.1* | - |
| | | | T _J = 25°C | 1.8 | 2.2 | 2.5 | |
| | | I _C = 15 A, V _{GE} = 4.0 V | T _J = 150°C | 2.0 | 2.4 | 2.6* | |
| | | | $T_J = -40^{\circ}C$ | 1.7 | 2.1 | 2.5 | |
| | | I _C = 10 A, V _{GE} = 4.5 V | $T_J = 25^{\circ}C$ | 1.3 | 1.8 | 2.0* | |
| | | | T _J = 150°C | 1.3 | 1.75 | 2.0* | |
| | | | $T_J = -40^{\circ}C$ | 1.4 | 1.8 | 2.0* | |
| Forward Transconductance | gfs | $V_{CE} = 5.0 \text{ V},$ $I_{C} = 6.0 \text{ A}$ | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 8.0 | 14 | 25 | Mhos |
| DYNAMIC CHARACTERISTICS | | · | | | | | |
| Input Capacitance | C _{ISS} | | | 400 | 800 | 1000 | pF |
| Output Capacitance | C _{OSS} | V _{CC} = 25 V, V _{GE} = 0 V f = 1.0 MHz | $T_J = -40^{\circ}C$ to $150^{\circ}C$ | 50 | 75 | 100 | |
| Transfer Capacitance | C _{RSS} | | | 4.0 | 7.0 | 10 | |
| SWITCHING CHARACTERISTICS | | · | | | | | |
| Turn-Off Delay Time (Resistive) | t _{d(off)} | | $T_J = 25^{\circ}C$ | - | 4.0 | 10 | μSec |
| Fall Time (Resistive) | t _f | | $T_J = 25^{\circ}C$ | _ | 9.0 | 15 | |
| Turn-On Delay Time | t _{d(on)} | | T _J = 25°C | - | 0.7 | 4.0 | μSec |
| Rise Time | t _r | $\begin{array}{l} V_{CC} = 10 \; \text{V}, \; \text{I}_{C} = 6.5 \; \text{A} \\ R_{G} = 1.0 \; \text{k}\Omega, \\ R_{L} = 1.5 \; \Omega \end{array}$ | T _J = 25°C | - | 4.5 | 7.0 | |

*Maximum Value of Characteristic across Temperature Range. 3. Pulse Test: Pulse Width \leq 300 μ S, Duty Cycle \leq 2%.

TYPICAL ELECTRICAL CHARACTERISTICS (unless otherwise noted)





Current versus Temperature

versus Temperature

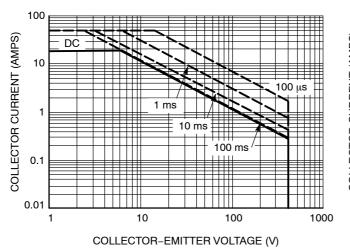
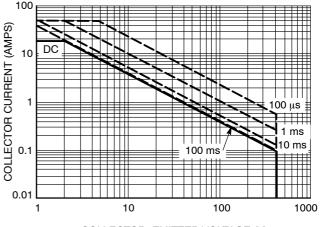


Figure 13. Single Pulse Safe Operating Area (Mounted on an Infinite Heatsink at $T_A = 25^{\circ}C$)



COLLECTOR-EMITTER VOLTAGE (V)

Figure 14. Single Pulse Safe Operating Area (Mounted on an Infinite Heatsink at $T_A = 125^{\circ}C$)

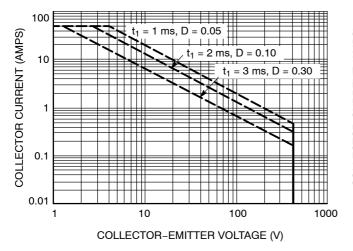
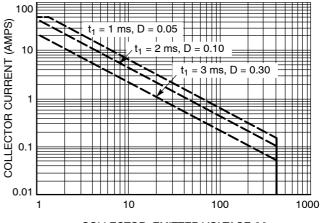
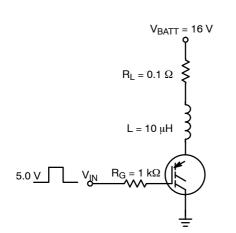


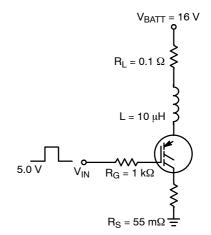
Figure 15. Pulse Train Safe Operating Area (Mounted on an Infinite Heatsink at $T_C = 25^{\circ}C$)



COLLECTOR-EMITTER VOLTAGE (V)

Figure 16. Pulse Train Safe Operating Area (Mounted on an Infinite Heatsink at $T_C = 125^{\circ}C$)









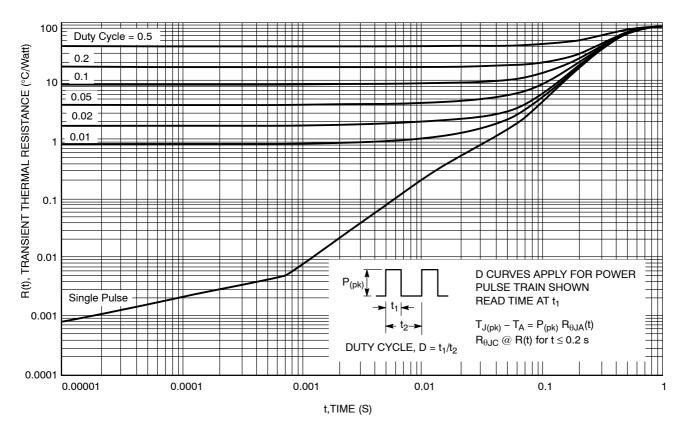
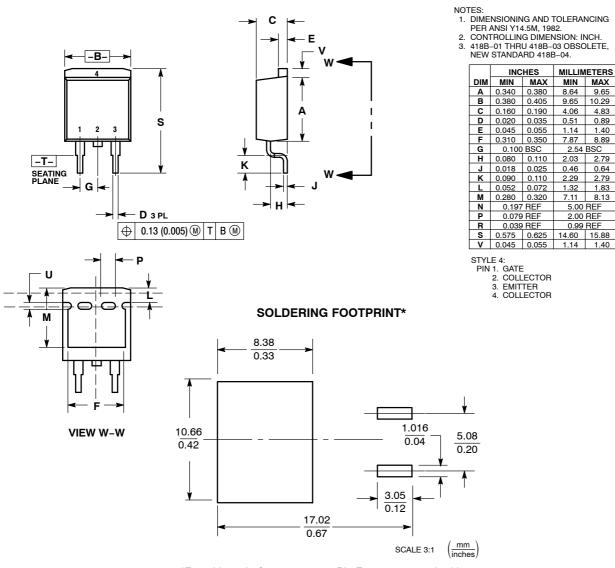


Figure 19. Transient Thermal Resistance (Non-normalized Junction-to-Ambient mounted on minimum pad area)

PACKAGE DIMENSIONS

D²PAK 3 CASE 418B-04 ISSUE J



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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